

**Search Notes**

Application/Control No.

10/099,626

Examiner

Pablo N. Tran

Applicant(s)/Patent under  
Reexamination

SEPPINEN ET AL.

Art Unit

2685

**SEARCHED**

Class	Subclass	Date	Examiner
455	226.1	07/26/03	PL
67-4			
12-1			
427			
67-1			
67-7			
226.2			
226.3			
226.4			
375	224		
211			
345			
213-216			
224			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner